

<b>Notice of References Cited</b>	Application/Control No. 10/552,902		Applicant(s)/Patent Under Reexamination WEIDMANN, ULRICH	
	Examiner MEGAN ARNBERG		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,914,236 A	10-1975	Lerch et al.	546/143
*	B	US-4,463,011 A	07-1984	Ogata et al.	514/397
*	C	US-4,602,022 A	07-1986	Cozzi et al.	514/337
*	D	US-5,134,111 A	07-1992	Okita et al.	562/466
*	E	US-2002/0111422 A1	08-2002	Back et al.	524/602
*	F	US-6,555,690 B2	04-2003	Johnson et al.	546/309
*	G	US-2004/0009976 A1	01-2004	Takeuchi et al.	514/228.2
*	H	US-6,713,632 B1	03-2004	Kawakami, Jun-ichi	548/335.1
*	I	US-2006/0247259 A1	11-2006	Funahashi et al.	514/265.1
*	J	US-7,323,485 B2	01-2008	Chow et al.	514/396
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	CH 648844 A5	04-1985	Switzerland	MIXICH et al.	C07D409/12
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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